



## ELECTRONIC INFORMATION DISCLOSURE STATEMENT

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Title of Invention	METHOD AND APPARATUS FOR HIGH SENSITIVITY MONITORING OF MOLECULAR CONTAMINATION																																																																																						
<p>Application Number: 10/634464</p> <p>Confirmation Number: 6738</p> <p>First Named Applicant: Daniel Rodier</p> <p>Attorney Docket Number: 13183.174US</p> <p>Art Unit: 2856</p> <p>Examiner: Unknown Unknown</p> <p>Search string: ( 5321331 or 5627749 or 5856198 or 5859537 or 5918258 or 6079252 or 6122954 or 6378370 or 6490927 ).pn.</p>																																																																																							
<h3>US Patent Documents</h3> <p>Note: Applicant is not required to submit a paper copy of cited US Patent Documents</p> <table border="1"><thead><tr><th>Init</th><th>Cite.No.</th><th>Patent No..</th><th>Date</th><th>Patentee</th><th>Kind</th><th>Class</th><th>Subclass</th></tr></thead><tbody><tr><td></td><td>1</td><td>5321331</td><td>1994-06-14</td><td>Baer et al</td><td>A</td><td>310</td><td>313</td></tr><tr><td></td><td>2</td><td>5627749</td><td>1997-05-06</td><td>Waterman et al.</td><td>A</td><td>364</td><td>422</td></tr><tr><td></td><td>3</td><td>5856198</td><td>1999-01-05</td><td>Joffe et al.</td><td>A</td><td>436</td><td>100</td></tr><tr><td></td><td>4</td><td>5859537</td><td>1999-01-12</td><td>Davis et al.</td><td>A</td><td>324</td><td>693</td></tr><tr><td></td><td>5</td><td>5918258</td><td>1999-06-29</td><td>William D. Bowers</td><td>A</td><td>73</td><td>24.06</td></tr><tr><td></td><td>6</td><td>6079252</td><td>2000-06-27</td><td>Tabler et al.</td><td>A</td><td>73</td><td>40</td></tr><tr><td></td><td>7</td><td>6122954</td><td>2000-09-26</td><td>William D. Bowers</td><td>A</td><td>73</td><td>24.06</td></tr><tr><td></td><td>8</td><td>6378370</td><td>2002-04-30</td><td>Haskell et al.</td><td>B1</td><td>73</td><td>579</td></tr><tr><td></td><td>9</td><td>6490927</td><td>2002-12-10</td><td>Braunling et al.</td><td>B2</td><td>73</td><td>597</td></tr></tbody></table>								Init	Cite.No.	Patent No..	Date	Patentee	Kind	Class	Subclass		1	5321331	1994-06-14	Baer et al	A	310	313		2	5627749	1997-05-06	Waterman et al.	A	364	422		3	5856198	1999-01-05	Joffe et al.	A	436	100		4	5859537	1999-01-12	Davis et al.	A	324	693		5	5918258	1999-06-29	William D. Bowers	A	73	24.06		6	6079252	2000-06-27	Tabler et al.	A	73	40		7	6122954	2000-09-26	William D. Bowers	A	73	24.06		8	6378370	2002-04-30	Haskell et al.	B1	73	579		9	6490927	2002-12-10	Braunling et al.	B2	73	597
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